# MOTOROLA SEMICONDUCTOR TECHNICAL DATA

# MBR8035 MBR8045

MBR8045 is a Motorola Preferred Device

## **Switchmode Power Rectifiers**

... using a platinum barrier metal in a large area metal-to-silicon power diode. State-of-the-art geometry features epitaxial construction with oxide passivation and metal overlap contact. Ideally suited for use as rectifiers in low-voltage, high-frequency inverters, free-wheeling diodes, and polarity-protection diodes.

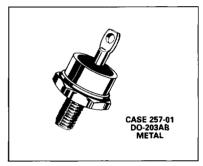
- · Guaranteed Reverse Avalanche
- · Guardring for dv/dt Stress Protection
- 175°C Operating Junction Temperature
- Low Forward Voltage

#### **Mechanical Characteristics:**

- · Case: Welded steel, hermetically sealed
- Weight: 17 grams (approximately)
- Finish: All External Surfaces Corrosion Resistant and Terminal Lead is Readily Solderable
- Solder Heat: The excellent heat transfer property of the heavy duty copper anode terminal
  which transmits heat away from the die requires that caution be used when attaching
  wires. Motorola suggests a heat sink be clamped between the eyelet and the body during
  any soldering operation.
- · Stud Torque: 25 lb-in max
- · Shipped 25 units per rail
- · Marking: B8035, B8045

### **SCHOTTKY RECTIFIERS**

80 AMPERES 35 and 45 VOLTS

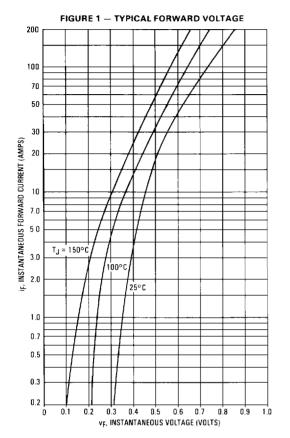


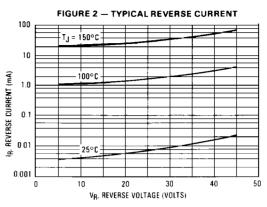
### **MAXIMUM RATINGS**

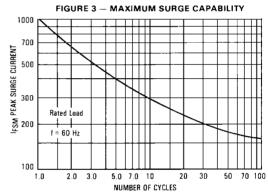
Rating	Symbol	MBR8035	MBR8045	Unit
Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	VRRM VRWM VR	35	45	Volts
Peak Repetitive Forward Current (Rated V <sub>R</sub> , Square Wave, 20 kHz) T <sub>C</sub> = 120°C	IFRM	160	160	Amps
Average Rectified Forward Current (Rated $V_R$ ) $T_C = 120$ °C	10	80	80	Amps
Peak Repetitive Reverse Surge Current (2.0 μs, 1.0 kHz) See Figure 7	IRRM	2.0	2.0	Amps
Nonrepetitive Peak Surge Current (Surge applied at rated load conditions halfwave, single phase, 60 Hz)	<sup>l</sup> FSM	1000	1000	Amps
Operating Junction Temperature and Storage Temperature	T <sub>J</sub> , T <sub>Stg</sub>	-65 to +175	-65 to +175	°C
Voltage Rate of Change (Rated V <sub>R</sub> )	dv/dt	1000	10000	V/μs
THERMAL CHARACTERISTICS	=::			
Maximum Thermal Resistance, Junction to Case	$R_{ heta JC}$	0.80	0.80	°C/W
ELECTRICAL CHARACTERISTICS	•	•	•	
Maximum Instantaneous Forward Voltage (1) (iF = 80 Amp, T <sub>C</sub> = 25°C) (iF = 80 Amp, T <sub>C</sub> = 150°C) (iF = 160 Amp, T <sub>C</sub> = 150°C)	٧F	0.72 0.59 0.67	0.72 0.59 0.67	Volts
Maximum Instantaneous Reverse Current (1) (Rated Voltage, $T_C$ = 25°C) (Rated Voltage, $T_C$ = 150°C)	İR	1.0 150	1.0 150	mA
Capacitance (V <sub>R</sub> $\approx$ 1.0 Vdc, 100 kHz $\leqslant$ f $\leqslant$ 1.0 MHz)	C <sub>t</sub>	5000	5000	pF

(1) Pulse Test: Pulse Width = 300 µs, Duty Cycle ≤ 2.0%

Rev 1



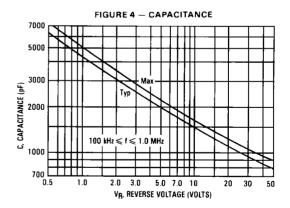




# NOTE 1 HIGH FREQUENCY OPERATION

Since current flow in a Schottky rectifier is the result of majority carrier conduction, it is not subject to junction diode forward and reverse recovery transients due to minority carrier injection and stored charge. Satisfactory circuit analysis work may be performed by using a model consisting of an ideal diode in parallel with a variable capacitance. (See Figure 4.)

Rectification efficiency measurements show that operation will be satisfactory up to several megahertz. For example, relative waveform rectification efficiency is approximately 70 per cent at 2.0 MHz, e.g., the ratio of dc power to RMS power in the load is 0.28 at this frequency, whereas perfect rectification would yield 0.406 for sine wave inputs. However, in contrast to ordinary junction diodes, the loss in waveform efficiency is not indicative of power loss; it is simply a result of reverse current flow through the diode capacitance, which lowers the dc output voltage.



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0.0

0.01

0.02

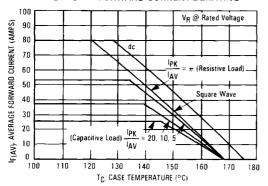
0.05

0.2

0.5

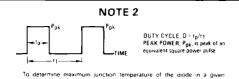
1.0

### FIGURE 5 -- FORWARD CURRENT DERATING



#### FIGURE 6 - POWER DISSIPATION 80 PF(AV), AVERAGE POWER DISSIPATION (WATTS) (Resistive Load) 60 lPK 50 (Capacitive Load) - IAV = 5 AV I 40 dc 30 Square Wave 20 10 70 ٤٥ 10 0 IF(AV), AVERAGE FORWARD CURRENT (AMPS)

### FIGURE 7 - TEST CIRCUIT FOR dv/dt AND REVERSE SURGE CURRENT



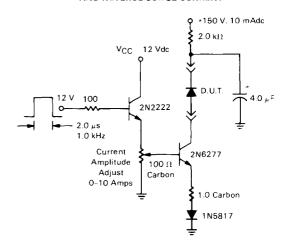
situation, the following procedure is recommended:

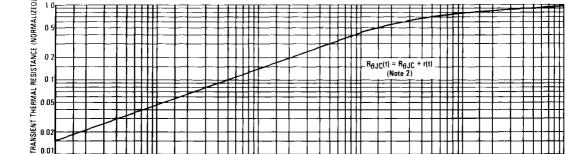
The temperature of the case should be measured using a thermocouple placed on the case. The thermal mass connected to the case is normally large enough so that it will not significantly respond to heat surges generated in the diode as a result of pulsed operation once steady-state conditions are achieved. Using the measured value of TC, the junction temperature may be

determined by  $T_{J} = T_{C} + \Delta T_{JC}$  where  $\Delta T_{C}$  is the increase in junction temperature above the case temperature. It may be determined by:

 $\Delta T_{JC} = P_{pk} \cdot R_{\theta,JC} (D \cdot (1 - D) \cdot r(t_1 + t_p) + r(t_p) - r(t_1))$  where r(t) - normalized value of transient thermal resistance at time, t, from

 $r(t_1-t_p)$  - normalized value of transient thermal resistance at time  $t_1+t_p$ 





2.0

t, TIME (ms)

5.0

10

20

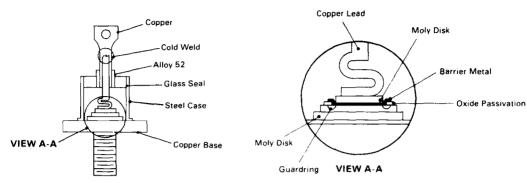
50

FIGURE 8 -- THERMAL RESPONSE

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### MBR8035, MBR8045

### FIGURE 9 - SCHOTTKY RECTIFIER



Motorola builds quality and reliability into its Schottky Rectifiers. First is the chip, which has an interface metal between the platinum-barrier metal and nickel-gold ohmic-contact metal to eliminate any possible interaction with the barrier. The indicated guardring prevents dv/dt problems, so snubbers are not mandatory. The guardring also operates like a zener to absorb overvoltage transients.

Second is the package. There are molybdenum disks which closely match the thermal coefficient of expansion of silicon on each side of the chip. The top copper lead has a stress relief

feature which protects the die during assembly. These two features give the unit the capability of passing stringent thermal fatigue tests for 5,000 cycles. The top copper lead provides a low resistance to current and therefore does not contribute to device heating; a heat sink should be used when attaching wires.

Third is the redundant electrical testing. The device is tested before assembly in "sandwich" form, with the chip between the moly disks. It is tested again after assembly. As part of the final electrical test, devices are 100% tested for dv/dt at 1,600 V/ $\mu s$  and reverse avalanche.

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